Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/047,540	RITZ ET AL.
Examiner	Art Unit
Annan Q. Shang	2623

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Class	Subclass	Date	Examiner	
725	4,10- 14,34- 36,47,60,6 1,87,104	9/11/2006	A.S	
725	109	9/11/2006	A.S	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	′)
	DATE	EXMR
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